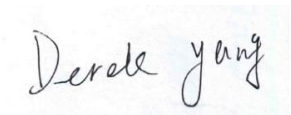
FCC TEST REPORT

Application No:	ZR/2020/50024
Applicant:	Xiaomi Communications Co., Ltd.
Address of Applicant	#019, 9th Floor, Building 6, 33 Xi'erqi Middle Road, Haidian District, Beijing, China, 100085
Manufacturer:	Xiaomi Communications Co., Ltd.
Address of Manufacturer:	#019, 9th Floor, Building 6, 33 Xi'erqi Middle Road, Haidian District, Beijing, China, 100085
EUT Description:	Mobile Phone
Model No.:	M2002J9R
Trade Mark:	MI
FCC ID:	2AFZZJ9G
Standards:	47 CFR Part 2 47 CFR Part 22 subpart H 47 CFR Part 27 subpart C 47 CFR Part 90 subpart S
Test Method:	FCC KDB 971168 D01 Power Meas License Digital Systems V03r01 C63.26 (2015)
Date of Receipt:	2020/6/2
Date of Test:	2020/6/2 to 2020/6/8
Date of Issue:	2020/6/11
Test Result:	**PASS ***

* In the configuration tested, the EUT detailed in this report complied with the standards specified above.

Authorized Signature:



Derek Yang
Wireless Laboratory Manager

1 Version

Revision Record				
Version	**Chapter**	**Date**	**Modifier**	**Remark**
00		2020/6/11		Original

Authorized for issue by:				
Tested By		Mike Hu **(Mike Hu) /Project Engineer**		
Checked By		David Chen **(David Chen) /Reviewer**		

Remark:
The difference between M2002J9G and M2002J9R are showed as below:

1. Dual SIM to single SIM.
2. Adjusting the No.2 Antenna matching, it did not influence the Antenna's performance, only changed the peak efficiency point from 3400 MHz to 3700 MHz.
3. Support bands were update through SW ,the bands listing As below:

	M2002J9G	M2002J9R
HW	Dual SIM	Single SIM
	/	Adjusting the No.2 Antenna matching
Bands	GSM 2/3/5/8 WCDMA 1/2/4/5/8 LTE 1/2/3/4/5/7/8/20/28/38/40/41 2UL CA:3C,7C,38C,40C	GSM 2/3/5/8 WCDMA 1/2/4/5/8 LTE 1/2/3/4/5/7/8/18/20/26/28/38/40/41/42 2UL CA:3C,7C,38C,40C,41C,42C

Except listings above, the others are all the same as previous version.

According to the difference above, LTE band 26 and UL CA_41C were fully tested on M2002J9R, RSE were retested for other bands,Since the data has not deteriorated,all other data of M2002J9R can refer to the report of M2002J9G (Report No.: ZR/2020/2002901).

Content

SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch Testing Technology EMC Laboratory.

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2 Test Summary

2.1 LTE Band 26 824MHz-849MHz

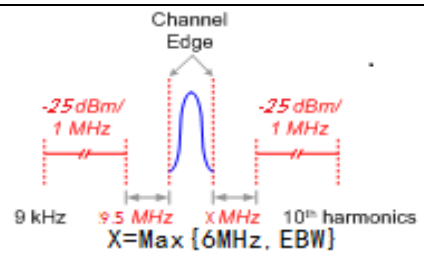
Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §22.913	FCC: ERP ≤ 7 W	Section 1 of Appendix B	Pass
Peak-Average Ratio	---	Limit≤13 dB	Section 2 of Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B	Pass
Band Edges Compliance	§2.1051, §22.917	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Section 5 of Appendix B	Pass
Spurious Emission at Antenna Terminals	§2.1051, §22.917	FCC: ≤ -13 dBm/100 kHz, from 9 kHz to 10th harmonics but outside authorized operating frequency ranges.	Section 6 of Appendix B	Pass
Field Strength of Spurious Radiation	§2.1053, §22.917	FCC: ≤ -13 dBm/100 kHz.	Section 7 of Appendix B	Pass
Frequency Stability	§2.1055, §22.355	≤ ±2.5ppm.	Section 8 of Appendix B	Pass
Remark: For the verdict, the “N/A” denotes “not applicable”, the “N/T” denotes “not tested”.				

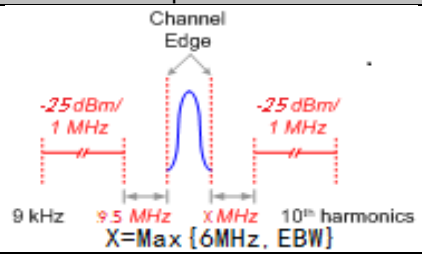
2.2 LTE Band 26 814MHz-824MHz

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Transmitter Conducted Power Output	§2.1046, §90.635	< 100 W.	Section 1 of Appendix B	PASS
Peak-Average Ratio	---	FCC: Limit≤13 dB	Section 2 of Appendix B	N/T
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B	PASS
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B	PASS
Emission Mask	§2.1051 § 90.691	For any frequency removed from the EA licensee’s frequency block by up to and including 37.5 kHz, the power of any emission shall be attenuated below the transmitter power (P) in watts by at least 116 Log10(f/6.1) decibels or 50+10Log10(P) decibels or 80 decibels, whichever is the lesser attenuation, where f is the frequency removed from the center of the outer channel in the block in kilohertz and where f is greater	Section 5 of Appendix B	PASS

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
		than 12.5 kHz.		
Spurious Emission at Antenna Terminals	§2.1051, §90.691	< 43 + 10Log10(P[Watts]) for all out-of-band emissions	Section 6 of Appendix B	PASS
Field Strength of Spurious Radiation	§2.1053, §90.691	< 43 + 10Log10(P[Watts]) for all out-of-band emissions	Section 7 of Appendix B	PASS
Frequency Stability	§2.1055, §90.213	< ±2.5ppm.	Section 8 of Appendix B	PASS
Remark: For the verdict, the “N/A” denotes “not applicable”, the “N/T” denotes “not tested”.				

2.3 LTE UL_CA_41C

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §27.50(h)	EIRP ≤ 2W	Section 1 of Appendix B	Pass
Peak-Average Ratio	§27.50(a)	≤13 dB	Section 2 of Appendix B	Pass
Modulation Characteristics	§2.1047	Digital modulation	Section 3 of Appendix B	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 4 of Appendix B	Pass
Band Edges Compliance	§2.1051, §27.53(m4)	For mobile digital stations, the attenuation factor shall be not less than 40 + 10 log (P) dB on all frequencies between the channel edge and 5 megahertz from the channel edge, 43 + 10 log (P) dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and 55 + 10 log (P) dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section.	Section 5 of Appendix B	Pass
Spurious Emission at Antenna Terminals	§2.1051, §27.53(m)		Section 6 of Appendix B	Pass

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Field Strength of Spurious Radiation	§2.1053, §27.53(m)		Section 7 of Appendix B	Pass
Frequency Stability	§2.1055, §27.54	Within authorized bands of operation/frequency block.	Section 8 of Appendix B	Pass
Remark: For the verdict, the “N/A” denotes “not applicable”, the “N/T” denotes “not tested”.				

3 General Information

3.1 Client Information

Applicant:	Xiaomi Communications Co., Ltd.
Address of Applicant:	#019, 9th Floor, Building 6, 33 Xi'erqi Middle Road, Haidian District, Beijing, China, 100085
Manufacturer:	Xiaomi Communications Co., Ltd.
Address of Manufacturer:	#019, 9th Floor, Building 6, 33 Xi'erqi Middle Road, Haidian District, Beijing, China, 100085

3.2 Test Location

Company:	SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch
Address:	No. 1 Workshop, M-10, Middle section, Science & Technology Park, Shenzhen, Guangdong, China
Post code:	518057
Telephone:	+86 (0) 755 2601 2053
Fax:	+86 (0) 755 2671 0594
E-mail:	ee.shenzhen@sgs.com

3.3 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

• CNAS (No. CNAS L2929)

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

• A2LA (Certificate No. 3816.01)

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

• VCCI

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

• FCC –Designation Number: CN1178

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

• Industry Canada (IC)

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

3.4 General Description of EUT

EUT Description:	Mobile Phone
Model No.:	M2002J9R
Trade Mark:	MI
Hardware Version:	P2.2
Software Version:	MIUI 11
Sample Type:	☒ Portable Device, ☐Module
Antenna Type:	☐ External, ☒ Integrated
Antenna Gain:	LTE Band 26: -4.5dBi (UP Ant); -4.6dBi (Down Ant); LTE Band 41C: -1.09dBi (UP Ant); -0.98dBi (Down Ant);

3.5 Test Mode

Test Mode	Test Modes Description
GSM/TM1	GSM system, GSM/GPRS, GMSK modulation
GSM/TM2	GSM system, EGPRS, 8PSK modulation
UMTS/TM1	UMTS system, WCDMA, QPSK modulation
UMTS/TM2	UMTS system, WCDMA, 16QAM modulation
LTE/TM1	LTE system, QPSK modulation
LTE/TM2	LTE system, 16QAM modulation
LTE/TM3	LTE system, 64QAM modulation

Remark: The test mode(s) are selected according to relevant radio technology specifications.

3.6 Test Environment

Environment Parameter	Selected Values During Tests	
Relative Humidity	52%	
Atmospheric Pressure:	101.32 KPa	
Temperature	NT	25 °C
Voltage:	LV	3.50V
	NV	3.80V
	HV	4.35V

Remark: LV= lower extreme test voltage; NV= nominal voltage
HV= upper extreme test voltage; NT= normal temperature

3.7 Technical Specification

Characteristics	Description		
Radio System Type	☒ GSM		
	☒ UMTS		
	☒ LTE		
Supported Frequency Range	Band	TX	RX
	GSM850	824 to 849 MHz	869 to 894 MHz
	GSM1900	1850 to 1910 MHz	1930 to 1990 MHz
	UMTS Band II	1850 to 1910 MHz	1930 to 1990 MHz
	UMTS Band IV	1710 to 1755 MHz	2110 to 2155 MHz
	UMTS Band V	824 to 849 MHz	869 to 894 MHz
	LTE Band 2	1850 to 1910 MHz	1930 to 1990 MHz
	LTE Band 4	1710 to 1755 MHz	2110 to 2155 MHz
	LTE Band 5	824 to 849 MHz	869 to 894 MHz
	LTE Band 7	2500 to 2570 MHz	2620 to 2690 MHz
	LTE Band 26 (814 to 824 MHz)	814 to 824MHz	859 to 869 MHz
	LTE Band 26 (824 to 849 MHz)	824 to 849 MHz	869 to 894 MHz
	LTE Band 38	2570 to 2620 MHz	2570 to 2620 MHz
	LTE Band 41	2496 to 2690MHz	2496 to 2690MHz
	LTE Band 7C	2500 to 2570 MHz	2620 to 2690 MHz
	LTE Band 38C	2570 to 2620 MHz	2570 to 2620 MHz
	LTE Band CA_41C	2496 to 2690 MHz	2496 to 2690 MHz
Target TX Output Power	LTE Band 26: 23.5dBm (Down Ant); 24.5dBm (Up Ant) LTE Band 41C: 24.0dBm (Down Ant); 23.5dBm (Up Ant)		
Supported Channel Bandwidth	LTE Band 26(814-824)	☒1.4 MHz;☒3 MHz; ☒5 MHz; ☒10 MHz;	
	LTE Band 26(824-849)	☒1.4 MHz;☒3 MHz; ☒5 MHz; ☒10 MHz; ☒15 MHz	
	LTE Band CA_41C	☒5MHz+20MHz ☒10MHz+15MHz ☒10MHz+20MHz ☒15MHz+15MHz	

		☒15MHz+20MHz ☒20MHz+20MHz
Characteristics	Description	
Designation of Emissions (Remark: the necessary bandwidth of which is the worst value from the measured occupied bandwidths for each type of channel bandwidth configuration.)	LTE Band 26 （814-824）	1M10G7D;1M09W7D; 1M10W7D 2M70G7D;2M69W7D; 2M69W7D 4M48G7D;4M48W7D; 4M49W7D 8M93G7D;8M95W7D; 8M93W7D
	LTE Band 26 （824-849）	1M09G7D;1M09W7D; 1M09W7D 2M70G7D;2M69W7D; 2M69W7D 4M48G7D;4M50W7D; 4M48W7D 8M93G7D;8M93W7D; 8M93W7D 13M5G7D;13M5W7D; 13M4W7D
	LTE Band CA_41C	25RB+100RB:22M8G7D;22M7W7D; 22M8W7D 50RB+75RB:23M1G7D;23M1W7D; 23M1W7D 50RB+100RB:27M7G7D;27M7W7D; 27M7W7D 75RB+50RB:23M2G7D;23M2W7D; 23M2W7D 75RB+75RB:28M3G7D;28M3W7D; 28M3W7D 75RB+100RB:32M7G7D;32M7W7D; 32M7W7D 100RB+25RB:23M0G7D;23M0W7D; 23M0W7D 100RB+50RB:27M8G7D;27M8W7D; 27M8W7D 100RB+75RB:32M7G7D;32M6W7D; 32M7W7D 100RB+100RB:37M6G7D;37M5W7D; 37M6W7D

3.8 Test Frequencies

Test Mode	Bandwidth	TX / RX	RF Channel		
			Low (L)	Middle (M)	High (H)
LTE Band26 (814-824)	1.4MHz	TX	Channel 26697	Channel 26740	Channel 26783
			814.7 MHz	819 MHz	823.3 MHz
		RX	Channel 8697	Channel 8740	Channel 8783
			859.7 MHz	864MHz	868.3 MHz
	3MHz	TX	Channel 26705	Channel 26740	Channel 26775
			815.5 MHz	819 MHz	822.5 MHz
		RX	Channel 8705	Channel 8740	Channel 8775
			860.5 MHz	864MHz	867.5 MHz
	5MHz	TX	Channel 26715	Channel 26740	Channel 26765
			816.5 MHz	819 MHz	821.5 MHz
		RX	Channel 8715	Channel 8740	Channel 8755
			861.5 MHz	864MHz	866.5 MHz
	10MHz	TX	Channel 26740	Channel 26740	Channel 26740
			819 MHz	819 MHz	819 MHz
		RX	Channel 8740	Channel 8740	Channel 8740
			864MHz	864MHz	864MHz

Test Mode	Bandwidth	TX / RX	RF Channel		
			Low (L)	Middle (M)	High (H)
LTE Band26 (824-849)	1.4MHz	TX	Channel 26797	Channel 26915	Channel 27033
			824.7 MHz	836.5 MHz	848.3 MHz
		RX	Channel 8697	Channel 8915	Channel 9033
			859.7 MHz	881.5 MHz	893.3 MHz
	3MHz	TX	Channel 26805	Channel 26915	Channel 27025
			825.5 MHz	836.5 MHz	847.5 MHz
		RX	Channel 8805	Channel 8915	Channel 9025
			860.5 MHz	881.5 MHz	892.5 MHz
	5MHz	TX	Channel 26815	Channel 26915	Channel 27015
			826.5 MHz	836.5 MHz	846.5 MHz
		RX	Channel 8815	Channel 8915	Channel 9015
			871.5 MHz	881.5 MHz	891.5 MHz
	10MHz	TX	Channel 26840	Channel 26915	Channel 26990
			829 MHz	836.5 MHz	844 MHz
		RX	Channel 8840	Channel 8915	Channel 8990
			874 MHz	881.5 MHz	889 MHz
	15MHz	TX	Channel 26865	Channel 26915	Channel 26965
			831.5 MHz	836.5 MHz	841.5 MHz
		RX	Channel 8865	Channel 8915	Channel 8965
			876.5 MHz	881.5 MHz	886.5 MHz

Table 4.3.1.2.9A-1: Test frequencies for CA_41C

Range	CC-Combo / N_{RB_agg} [RB]	CC1 Note1			CC2 Note1		
		BW [RB]	$N_{UL/DL}$	$f_{UL/DL}$ [MHz]	BW [RB]	$N_{UL/DL}$	$f_{UL/DL}$ [MHz]
Low	25+100	25	39683	2499.3	100	39800	2511
		100	39750	2506	25	39867	2517.7
	50+75	50	39703	2501.3	75	39823	2513.3
		75	39725	2503.5	50	39845	2515.5
	50+100	50	39705	2501.5	100	39849	2515.9
		100	39750	2506	50	39894	2520.4
	75+75	75	39725	2503.5	75	39875	2518.5
	75+100	75	39728	2503.8	100	39899	2520.9
		100	39750	2506	75	39921	2523.1
	100+100	100	39750	2506	100	39948	2525.8
Mid	25+100	25	40528	2583.8	100	40645	2595.5
		100	40595	2590.5	25	40712	2602.2
	50+75	50	40549	2585.9	75	40669	2597.9
		75	40571	2588.1	50	40691	2600.1
	50+100	50	40526	2583.6	100	40670	2598.0
		100	40571	2588.1	50	40715	2602.5
	75+75	75	40545	2585.5	75	40695	2600.5
	75+100	75	40523	2583.3	100	40694	2600.4
		100	40546	2585.6	75	40717	2602.7
	100+100	100	40521	2583.1	100	40719	2602.9
High	25+100	25	41373	2668.3	100	41490	2680
		100	41440	2675	25	41557	2686.7
	50+75	50	41395	2670.5	75	41515	2682.5
		75	41417	2672.7	50	41537	2684.7
	50+100	50	41346	2665.6	100	41490	2680
		100	41391	2670.1	50	41535	2684.5
	75+75	75	41365	2667.5	75	41515	2682.5
	75+100	75	41319	2662.9	100	41490	2680
		100	41341	2665.1	75	41512	2682.2
	100+100	100	41292	2660.2	100	41490	2680
Note 1: Carriers in increasing frequency order.							

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4 Description of Tests

4.1 Conducted Output Power

Measurement Procedure: FCC KDB 971168 D01 V03r01

The transmitter output was connected to a calibrated coaxial cable, attenuator and power meter, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The power output at the transmitter antenna port was determined by adding the value of the cable insertion loss to the power reading. The tests were performed at three frequencies (low channel, middle channel and high channel) and on the highest power levels, which can be setup on the transmitters.

Remark: Reference test setup 1

4.2 Effective (Isotropic) Radiated Power of Transmitter

Measurement Procedure: FCC KDB 971168 D01 V03r01 ; C63.26 (2015)

Calculate power in dBm by the following formula:

ERP (dBm) = Conducted Power (dBm) + antenna gain (dBd)

EIRP(dBm) = Conducted Power (dBm) + antenna gain (dBi)

EIRP=ERP+2.15dB

4.3 Occupied Bandwidth

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 4.2

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel, middle channel and high channel).The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.

Remark: Reference test setup 1

Test Settings

1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
2. RBW = 1 – 5% of the expected OBW
3. VBW ≥ 3 x RBW
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. The trace was allowed to stabilize
8. If necessary, steps 2 – 7 were repeated after changing the RBW such that it would be within 1 – 5% of the 99% occupied bandwidth observed in Step 7

4.4 Band Edge at Antenna Terminals

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 6.0

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at two frequencies (low channel and high channel).in the 1MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of 100kHz or 1% of the emission bandwidth of the fundamental emission of the transmitter may be employed. The EUT emission bandwidth is measured as the width of the signal between two points, outside of which all emission are attenuated at least 26dB below the transmitter power. The video bandwidth of the spectrum analyzer was set at thrice the resolution bandwidth. Detector Mode was set to peak or peak hold power.

Remark: Reference test setup 1

Test Settings

1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
2. Span was set large enough so as to capture all out of band emissions near the band edge
3. RBW ≥ 1% of the emission bandwidth
4. VBW ≥ 3 x RBW
5. Detector = RMS
6. Number of sweep points ≥ 2 x Span/RBW
7. Trace mode = trace average for continuous emissions, max hold for pulse emissions
8. Sweep time = auto couple
9. The trace was allowed to stabilize

4.5 Spurious And Harmonic Emissions at Antenna Terminal

Measurement Procedure: FCC KDB 971168 D01 V03r01

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyzer, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel and high channel).The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least 43 + 10 log(P) dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 1 MHz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Remark: Reference test setup 1

Test Settings

1. Start frequency was set to 30MHz and stop frequency was set to at least 10 * the fundamental frequency (separated into at least two plots per channel)
2. Detector = RMS
3. Trace mode = trace average for continuous emissions, max hold for pulse emissions
4. Sweep time = auto couple
5. The trace was allowed to stabilize
6. Please see test notes below for RBW and VBW settings

4.6 Peak-Average Ratio

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.7.1

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span mode.

Remark: Reference test setup 1

Test Settings

1. The signal analyzer's CCDF measurement profile is enabled
2. Frequency = carrier center frequency
3. Measurement BW > Emission bandwidth of signal
4. The signal analyzer was set to collect one million samples to generate the CCDF curve
5. The measurement interval was set depending on the type of signal analyzed. For continuous signals (>98% duty cycle), the measurement interval was set to 1ms. For burst transmissions, the spectrum analyzer is set to use an internal "RF Burst" trigger that is synced with an incoming pulse and the measurement interval is set to less than the duration of the "on time" of one burst to ensure that energy is only captured during a time in which the transmitter is operating at maximum power

4.7 Field Strength of Spurious Radiation

Measurement Procedure: FCC KDB 971168 D01 V03r01

Below 1GHz test procedure as below:

1). The EUT was powered ON and placed on a 80cm high table in the chamber. The antenna of the transmitter was extended to its maximum length.

2). The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.

3). Steps 1) and 2) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.

4). The transmitter was then removed and replaced with another antenna. The center of the antenna was approximately at the same location as the center of the transmitter.

5). A signal at the disturbance was fed to the substitution antenna by means of a non-radiating cable. With both the substitution and the receive antennas horizontally polarized, the receive antenna was raised and lowered to obtain a maximum reading at the test receiver. The level of the signal generator was adjusted until the measured field strength level in step 2) is obtained for this set of conditions.

6). The output power into the substitution antenna was then measured.

7). Steps 5) and 6) were repeated with both antennas polarized.

8) Calculate power in dBm by the following formula:

ERP(dBm) = Pg(dBm) – cable loss (dB) + antenna gain (dBd)

Where:

Pd is the dipole equivalent power, Pg is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to Pg [dBm] – cable loss [dB]. The calculated Pd levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of 43 + 10log10(Power [Watts]).

Above 1GHz test procedure as below:

1) Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber

2) Calculate power in dBm by the following formula:

EIRP(dBm) = Pg(dBm) – cable loss (dB) + antenna gain (dBi)

EIRP=ERP+2.15dB

Where:

Pg is the generator output power into the substitution antenna.

3. Test the EUT in the lowest channel, the middle channel the Highest channel

4. The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.

5. Repeat above procedures until all frequencies measured was complete

Remark: Reference test setup 3

4.8 Frequency Stability / Temperature Variation

Measurement Procedure:

Frequency stability testing is performed in accordance with the guidelines of FCC KDB 971168 D01 V03r01; ANSI/C63.26 (2015)

. The frequency stability of the transmitter is measured by:

a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.

b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within ±0.00025% (±2.5 ppm) of the center frequency.

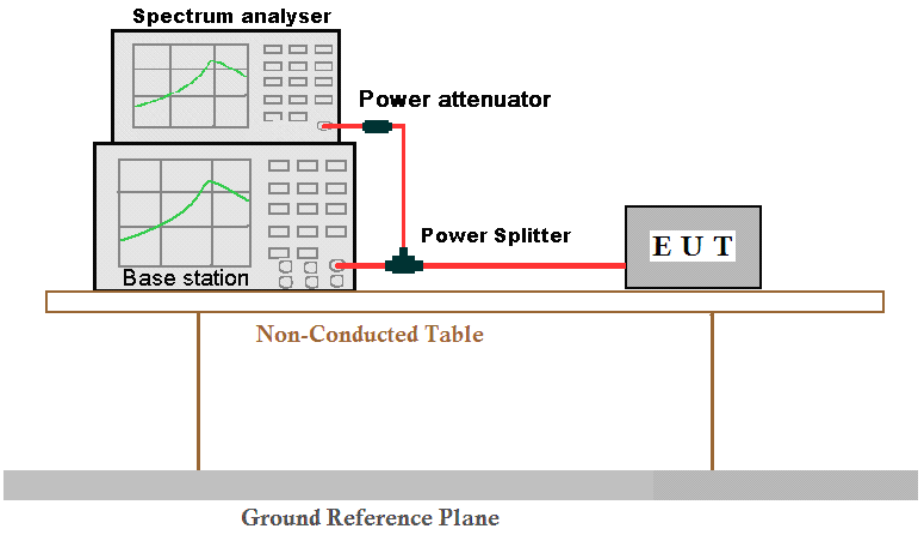
Time Period and Procedure:

1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
2. The equipment is turned on in a “standby” condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Remark: Reference test setup 4

4.9 Test Setups

4.9.1 Test Setup 1



4.9.2 Test Setup 2

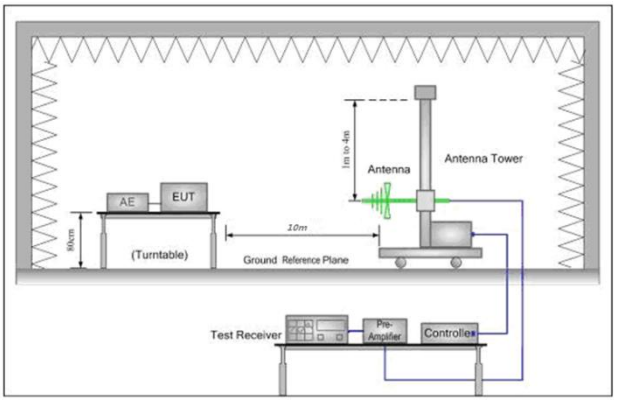


Figure 1. 30MHz to 1GHz

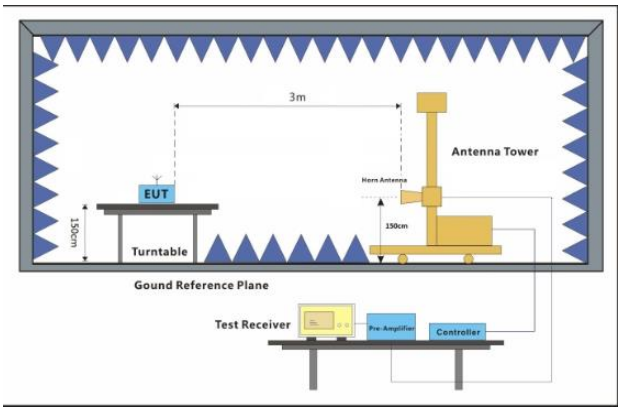


Figure 2. above 1GHz

4.9.3 Test Setup 3

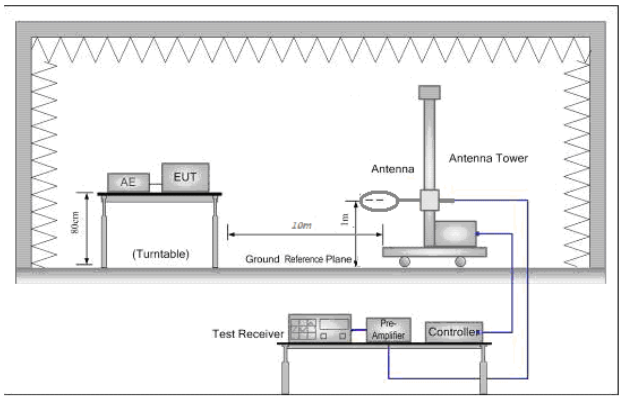


Figure 1. Below 30MHz

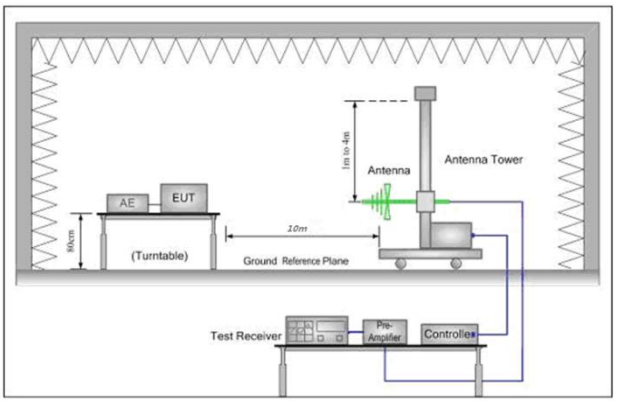


Figure 2. 30MHz to 1GHz

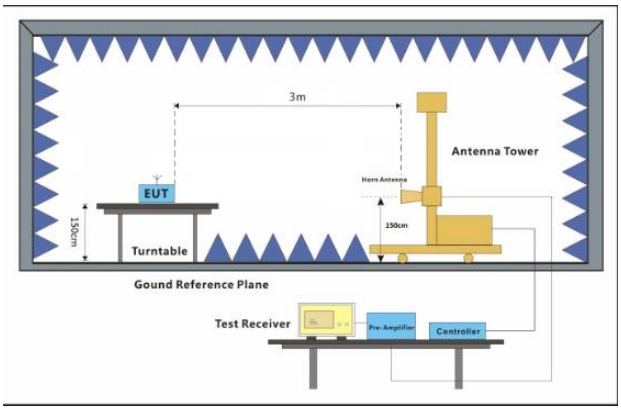
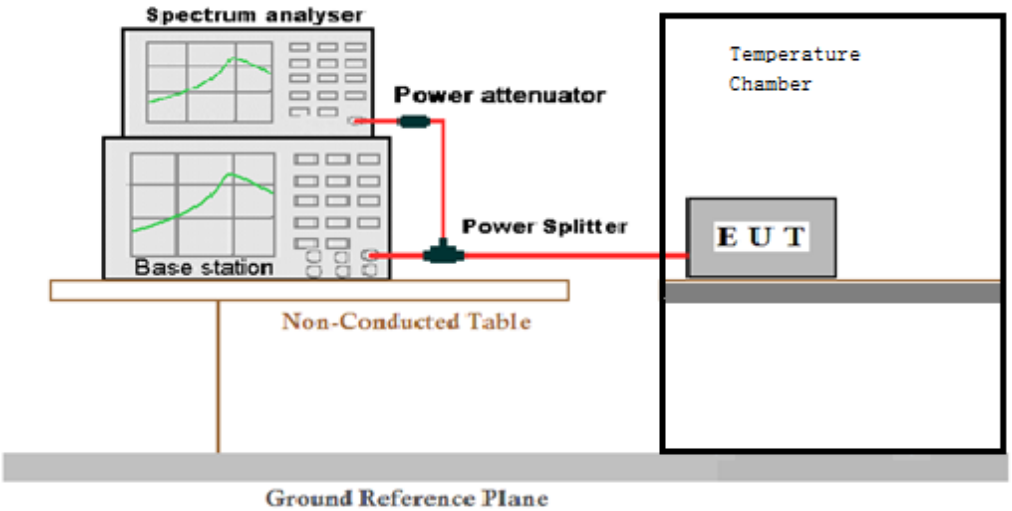


Figure 3. above 1GHz

4.9.4 Test Setup 4



4.10 Test Conditions

Test Case		Test Conditions	
Transmit Output Power Data	Average Power, Total	Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; UMTS/TM2; LTE/TM1;LTE/TM2;LTE/TM3
	Average Power, Spectral Density (if required)	Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; UMTS/TM2; LTE/TM1;LTE/TM2;LTE/TM3
Peak-to-Average Ratio (if required)		Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; UMTS/TM2; LTE/TM1;LTE/TM2;LTE/TM3
Modulation Characteristics		Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	M (M= middle channel)
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; UMTS/TM2; LTE/TM1;LTE/TM2;LTE/TM3
Bandwidth	Occupied Bandwidth	Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; UMTS/TM2; LTE/TM1;LTE/TM2;LTE/TM3
	Emission Bandwidth (if required)	Test Environment	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; UMTS/TM2; LTE/TM1;LTE/TM2;LTE/TM3

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Band Edges Compliance	Test Environment	Ambient Climate & Rated Voltage
	Test Setup	Test Setup 1
	RF Channels (TX)	L, H (L= low channel, H= high channel)
	Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; UMTS/TM2; LTE/TM1;LTE/TM2;LTE/TM3
Spurious Emission at Antenna Terminals	Test Environment	Ambient Climate & Rated Voltage
	Test Setup	Test Setup 1
	RF Channels (TX)	L,M, H (L= low channel, M= middle channel, H= high channel)
	Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; UMTS/TM2; LTE/TM1;LTE/TM2;LTE/TM3
Field Strength of Spurious Radiation	Test Environment	Ambient Climate & Rated Voltage
	Test Setup	Test Setup 2
	Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1;UMTS/TM2; LTE/TM1;LTE/TM2;LTE/TM3; Remark: If applicable, the EUT conf. that has maximum power density (based on the equivalent power level) is selected.
	RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Frequency Stability	Test Environment	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage; (2) VL, VN and VH of Rated Voltage at Ambient Climate.
	Test Setup	Test Setup 4
	RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
	Test Mode	GSM/TM1;GSM/TM2;UMTS/TM1; UMTS/TM2; LTE/TM1;LTE/TM2;LTE/TM3

5 Main Test Instruments

RE in Chamber					
Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Due date (yyyy-mm-dd)
3m Semi-Anechoic Chamber	AUDIX	N/A	SEM001-02	2018/3/13	2021/3/12
Spectrum Analyzer (20Hz-43GHz)	Rohde & Schwarz	FSU43	SEM004-08	2020/4/16	2021/4/15
BiConiLog Antenna (26-3000MHz)	ETS-Lindgren	3142C	SEM003-01	2017/6/27	2020/6/26
Horn Antenna (800MHz-18GHz)	Rohde & Schwarz	HF907	SEM003-07	2018/413	2021/412
Horn Antenna (15-40GHz)	Schwarzbeck	BBHA 9170	SEM003-15	2017/10/17	2020/10/16
Amplifier (0.1-1300MHz)	HP	8447D	SEM005-02	2019/7/14	2020/7/14
Low Noise Amplifier (100MHz-18GHz)	Black Diamond Series	BDLNA-0118-352810	SEM005-05	2019/7/14	2020/7/14
Pre-Amplifier (0.1-26.5GHz)	Compliance Directions Systems Inc.	PAP-0126	EMC2063	2019/9/20	2020/9/19
Pre-amplifier (26-40GHz)	Compliance Directions Systems Inc.	PAP-2640-50	SEM005-08	2020/4/16	2021/4/15
Band filter	N/A	N/A	N/A	N/A	N/A
Measurement Software	AUDIX	e3 V8.2014-6-27	N/A	N/A	N/A
Coaxial Cable	SGS	N/A	SEM026-01	2019/6/12	2020/6/11
Wideband Radio CommunicationTeste	Anristu	MT8821C	6201462742	2020/4/16	2021/4/15
Wideband Radio CommunicationTester	Rohde & Schwarz	CMW500	W005-02	2020/1/13	2021/1/2

RF conducted test					
Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. date (yyyy-mm-dd)	Cal.Due date (yyyy-mm-dd)
Dual Output Mobile Communication DC Source	Agilent Technologies Inc	66311B	W009-09	2019/10/22	2020/10/21
Signal Analyzer	Rohde & Schwarz	FSV	W005-02	2020/4/16	2021/4/15
Coaxial Cable	SGS	N/A	SEM031-01	2019/6/12	2020/6/11
Attenuator	Weinschel Associates	WA41	SEM021-09	N/A	N/A
Signal Generator	KEYSIGHT	N5173B	SEM006-05	2019/10/22	2020/10/21
Humidity/ Temperature Indicator	Shanghai Meteorological Industry Factory	HTC-1	W006-17	2019/10/22	2020/10/21
Temperature Chamber	GIANT FORCE	ICT-150-40-CP-AR	W027-03	2019/10/22	2020/10/21
Wideband Radio CommunicationTeste	Anristu	MT8821C	6201462742	2020/4/16	2021/4/15
Wideband Radio CommunicationTester	Rohde & Schwarz	CMW500	W005-02	2019/10/22	2020/10/21

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Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. Date (yyyy-mm-dd)	Cal. Due date (yyyy-mm-dd)
3m Semi-Anechoic Chamber	AUDIX	N/A	SEM001-02	2018/3/13	2021/3/12
Wideband Radio CommunicationTeste	Anristu	MT8821C	6201462742	2020/4/16	2021/4/15
Wideband Radio CommunicationTester	Rohde & Schwarz	CMW500	W005-02	2020/1/3	2021/1/2
EXA Signal Analyzer (10Hz-26.5GHz)	Agilent Technologies Inc	N9010A	SEM004-09	2020/3/13	2021/3/12
Spectrum Analyzer (20Hz-43GHz)	Rohde & Schwarz	FSU43	SEM004-08	2020/4/16	2021/4/15
BiConiLog Antenna (26-3000MHz)	ETS-Lindgren	3142C	SEM003-01	2017/6/27	2020/6/26
Horn Antenna (800MHz-18GHz)	Rohde & Schwarz	HF907	SEM003-07	2018/4/13	2021/4/12
Horn Antenna (15-40GHz)	Schwarzbeck	BBHA 9170	SEM003-15	2017/10/17	2020/10/16
Amplifier (0.1-1300MHz)	HP	8447D	SEM005-02	2019/7/25	2020/7/24
Pre-Amplifier (0.1-26.5GHz)	Compliance Directions Systems Inc.	PAP-0126	SEM004-11	2019/7/25	2020/7/24
Pre-amplifier (26-40GHz)	Compliance Directions Systems Inc.	PAP-2640-50	SEM005-08	2020/4/16	2021/4/15
Band filter	N/A	N/A	N/A	N/A	N/A
Coaxial Cable	SGS	N/A	SEM026-01	2019/6/12	2020/6/11
Tunable Notch Filter WRCD1700/2000-0.2/40-10EEK	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
Tunable Notch Filter WRCD800/960-0.2/40-10EEK	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
HighPass Filter WHK1.2/15G-10SS	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
HighPass Filter WHKX10-2700-3000-18000-40SS	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
HighPass Filter WHKX7.0/26.5G-6SS	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
Band Reject Filter WRCG 824/849-814/859-40/8SS	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
Band Reject Filter WRCG 1850/1910-1835/1925-40/8SS	WAINRIGHT Instruments GMBH	N/A	N/A	N/A	N/A
Measurement Software	AUDIX	e3 V8.2014-6-27	N/A	N/A	N/A

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6 Measurement Uncertainty

For a 95% confidence level (k = 2), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

Test Item	Extended Uncertainty	Data
Transmit Output Power Data	Power [dBm]	U =±0.37 dB
Bandwidth	Magnitude [%]	U =± 0.2%
Band Edge Compliance	Disturbance Power [dBm]	U = ±2.0 dB
Spurious Emissions, Conducted	Disturbance Power [dBm]	U = ±2.0 dB
Field Strength of Spurious Radiation	ERP[dBm]/EIRP [dBm]	For 3 m Chamber: U = ±4.5 dB (30 MHz to 1GHz) U = ±3.3 dB (above 1 GHz) For 10 m Chamber: U = ±4.5 dB (30 MHz to 1GHz) U = ±3.2 dB (above 1 GHz)
Frequency Stability	Frequency Accuracy [ppm]	U = ±0.24 ppm

7 Appendixes

Appendix A	Photographs of Set-Up for ZR/2020/50024.
Appendix B.1	LTE Band 26(814-824)
Appendix B.2	LTE Band 26(824-849)
Appendix B.3	LTE Band 41C

The End